# TC75S58AFE,TC75S58AFC

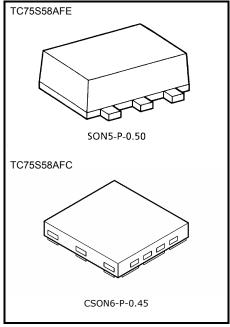
Single Comparator (Open-Drain Output)

The TC75S58AFE and TC75S58AFC are CMOS general-purpose single comparators. The devices can operate from a single supply voltage and are designed for a lower supply-current than conventional general-purpose bipolar comparators. The output is designed for Open-Drain Output and can supply a higher voltage than the power supply. Therefore, it is possible to pull-up the voltage to a level higher than that of the power supply. The Open-Drain Output can be wired-OR with another Open-Drain Output circuit.

\* Output voltage should not exceed the maximum rating

## **Feature**

- Low Supply Current: I<sub>DD</sub> = 10 μA (Typ.)
- Single Power Supply Operation
- Wide Common Mode Input: V<sub>SS</sub>~V<sub>DD</sub> 0.9 V
- · Open-Drain Output Circuit
- Low Input Bias Current
- Small Package

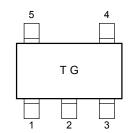


Weight

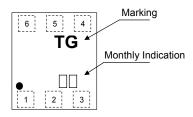
SON5-P-0.50 : 0.003 g (Typ.) CSON6-P-0.45 : 0.002 g (Typ.)

## Marking (top view)

## TC75S58AFE

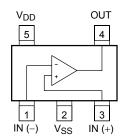


TC75S58AFC

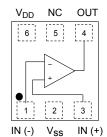


### Pin Assignment (top view)

## TC75S58AFE



TC75S58AFC



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## **Absolute Maximum Ratings (Ta = 25°C)**

Characteristics	Symbol	Rating		Unit	
Supply Voltage	V <sub>DD</sub> , V <sub>SS</sub>	±3.5 or 7		V	
Differential Input Voltage	DV <sub>IN</sub>	±7		V	
Input Voltage	V <sub>IN</sub>	V <sub>SS</sub> ~V <sub>DD</sub>		V	
Output Current	IO	±35		mA	
Output Voltage	Vo	V <sub>SS</sub> ~ V <sub>SS</sub> + 7		V	
Power Dissipation	PD	TC75S58AFE	100	mW	
		TC75S58AFC	100 (Note1)	IIIVV	
Operating Temperature	T <sub>opr</sub>	-40~85		°C	
Storage Temperature	T <sub>stg</sub>	-55~125		°C	

Note: Due to the CMOS structure, this device may be susceptible to latch-up . To prevent latch-up, please take the following precautions;

- Ensure that no I/O pin's voltage level ever exceeds Vdd or drops below Vss. In addition, check the power-on timing.
- Do not subject the device to excessive noise.

 $(Note~1~)~:~FR4~in~board~implementation \\ (25.4mm~\times~25.4mm~\times~1.6t,~Cu~Pad:~0.4mm^2)$ 



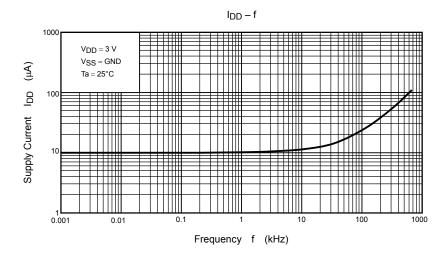
# Electrical Characteristics (V<sub>DD</sub> = 5 V, V<sub>SS</sub> = GND, Ta = 25°C)

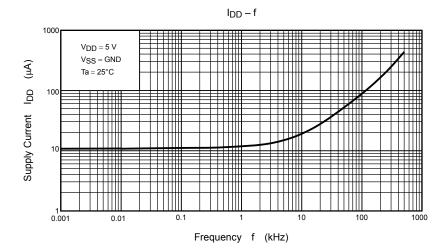
Characteristics	Symbol	Test Circuit	Test Condition	Min.	Тур.	Max.	Unit
Input Offset Voltage	V <sub>IO</sub>	_	_	_	±1	±7	mV
Input Offset Current	I <sub>IO</sub>	_	_	_	1	_	pА
Input Bias Current	lı	_	_	_	1	_	pА
Common Mode Input Voltage	CMV <sub>IN</sub>	_	_	0	_	4.1	V
Supply Current	I <sub>DD</sub> (注)	_	_	_	11	22	μΑ
Voltage Gain	G <sub>V</sub>	_	_	_	94	_	dB
Sink Current	I <sub>sink</sub>	_	V <sub>OL</sub> = 0.5 V	13	25	_	mA
Output Leakage Current	I <sub>LEAK</sub>	_	V <sub>DD</sub> = 5 V , V <sub>O</sub> = 5 V	_	5	_	nA
Off-State Leakage Current	l <sub>OFF</sub>	_	$V_{DD} = 0 \text{ V}$ , $V_{O} = 5 \text{ V}$	_	5	_	nA
Output-Low Voltage	V <sub>OL</sub>	_	I <sub>sink</sub> = 5.0 mA	_	0.1	0.3	V
Operating Supply Voltage Range	V <sub>DD</sub>	_	_	1.8	_	7.0	V
Propagation Delay (Turn On)	tPLH (1)	_	Over Drive = 100 mV	_	800	_	
	t <sub>PLH</sub> (2)	_	TTL Step Input	_	620	_	ns
Propagation Delay (Turn Off)	t <sub>PHL</sub> (1)	_	Over Drive = 100 mV	_	230	_	
	t <sub>PHL</sub> (2)	_	TTL Step Input	_	350	_	ns
Response Time	t <sub>TLH</sub>	_	Over Drive = 100 mV	_	190	_	20
	t <sub>THL</sub>	_	Over Drive = 100 mV	_	6	_	ns

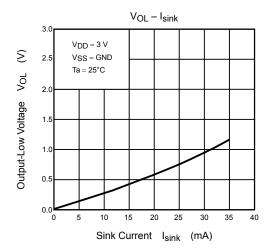
# Electrical Characteristics ( $V_{DD} = 3 \text{ V}, V_{SS} = GND, Ta = 25^{\circ}\text{C}$ )

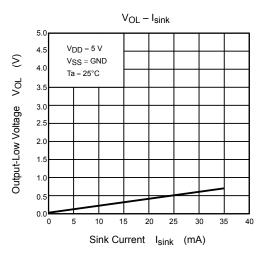
Characteristics	Symbol	Test Circuit	Test Condition	Min.	Тур.	Max.	Unit
Input Offset Voltage	V <sub>IO</sub>	_	_	_	±1	±7	mV
Input Offset Current	I <sub>IO</sub>	_	_	_	1	_	pA
Input Bias Current	II	_	_	_	1	_	pА
Common Mode Input Voltage	CMV <sub>IN</sub>	_	_	0	_	2.1	V
Supply Current	I <sub>DD</sub> (Note)	_	_	_	10	20	μА
Sink Current	I <sub>sink</sub>	_	V <sub>OL</sub> = 0.5 V	6	18	_	mA
Output Leakage Current	I <sub>LEAK</sub>	_	$V_{DD} = 3 V$ , $V_{O} = 3 V$	_	5	_	nA
Off-State Leakage Current	I <sub>OFF</sub>	_	$V_{DD} = 0 V$ , $V_{O} = 3 V$	_	5	_	nA
Output-Low Voltage	V <sub>OL</sub>	_	I <sub>sink</sub> = 5.0 mA	_	0.15	0.35	٧
Propagation Delay (Turn On)	t <sub>PLH</sub>	_	Over Drive = 100 mV		590		ns
Propagation Delay (Turn Off)	t <sub>PHL</sub>	_	Over Drive = 100 mV	_	230	_	ns
Response Time	t <sub>TLH</sub>	_	Over Drive = 100 mV	_	170	_	ns
	t <sub>THL</sub>	_	Over Drive = 100 mV		5		119

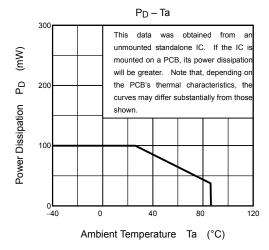
Note:The current consumption of this device increases as its operating frequency increases. Note that the power dissipation should not exceed the allowable power.







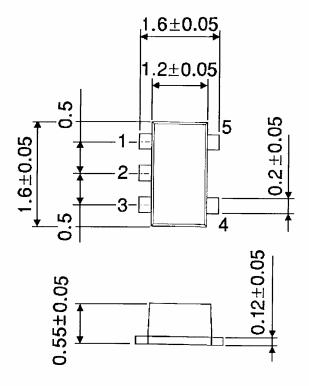




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# **Package Dimension**

SON5-P-0.50 Unit: mm

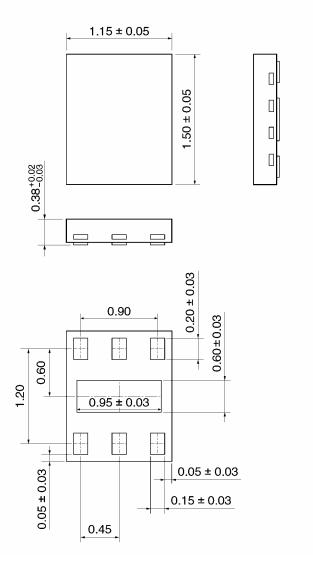


Weight: 0.003 g (Typ.)

# **Package Dimension**

CSON6-P-0.45

Unit: mm



Weight: 0.002 g (Typ.)

#### **RESTRICTIONS ON PRODUCT USE**

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